

**Search Notes**

Application/Control No.

10/615,153

Examiner

Michael Peffley

Applicant(s)/Patent under  
Reexamination

OHYAMA ET AL.

Art Unit

3739

**SEARCHED**

Class	Subclass	Date	Examiner
606	27-31, 41, 42, 45-50	6/14/2005	MP
607	101-105	6/14/2005	MP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR